



High-Voltage Switching Applications

Applications

· Power supplies, relay drivers, lamp drivers.

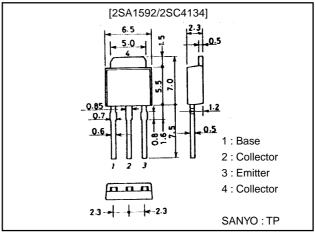
Features

- · Adoption FBET, MBIT processes.
- · High breakdown voltage and large current capacity.
- · Fast switching speed.
- · Small and slim package permitting 2SA1592/ 2SC4134-applied sets to be made more compact.

Package Dimensions

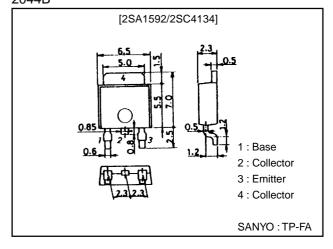
unit:mm

2045B



unit:mm

2044B



(): 2SA1592

Specifications

Absolute Maximum Ratings at Ta = 25°C

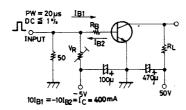
Parameter	Symbol	Conditions	Ratings	Unit
Collector-to-Base Voltage	V _{CBO}		(–)120	V
Collector-to-Emitter Voltage	VCEO		(–)100	V
Emitter-to-Base Voltage	V _{EBO}		(–)6	V
Collector Current	IC		(–)1	Α
Collector Current (Pulse)	ICP		(-)2	Α
Collector Dissipation	PC		0.8	W
		Tc=25°C	10	W
Junction Temperature	Tj		150	°C
Storage Temperature	Tstg		-55 to +150	°C

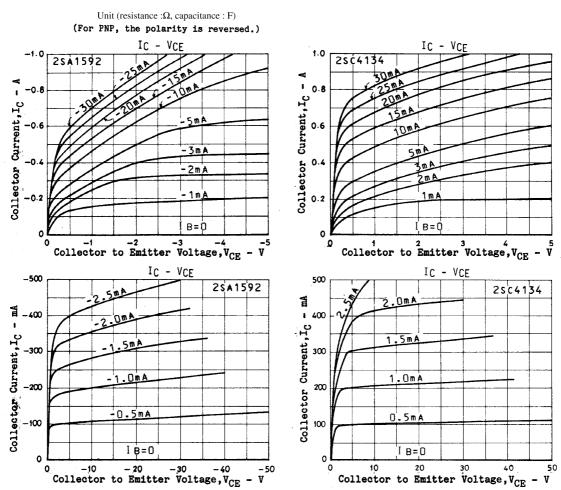
^{* :} The 2SA1592/2SC4134 are classified by 100mA h_{FE} as follows :

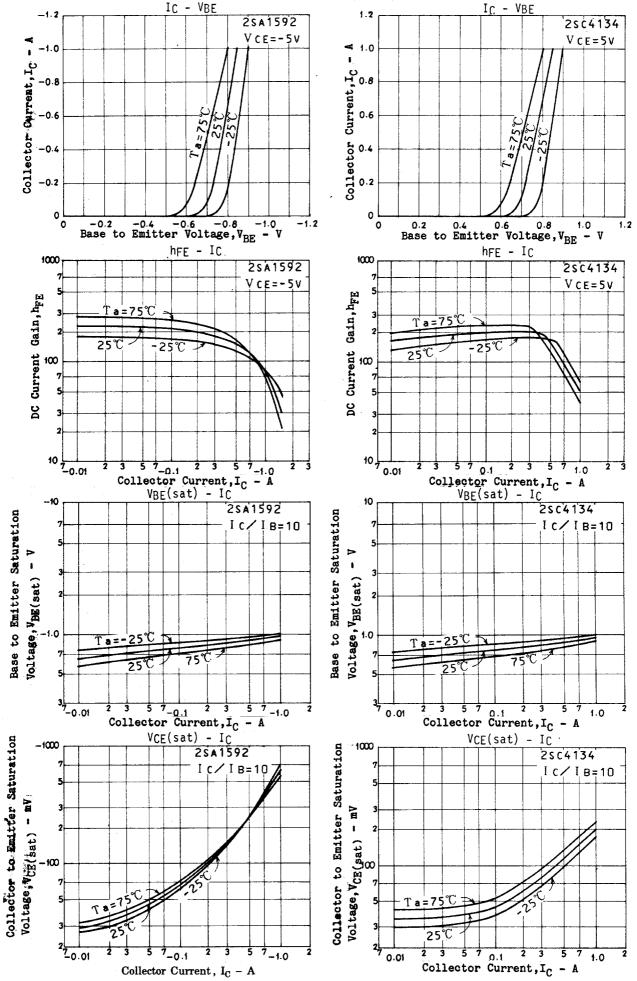
Electrical Characteristics at Ta = 25°C

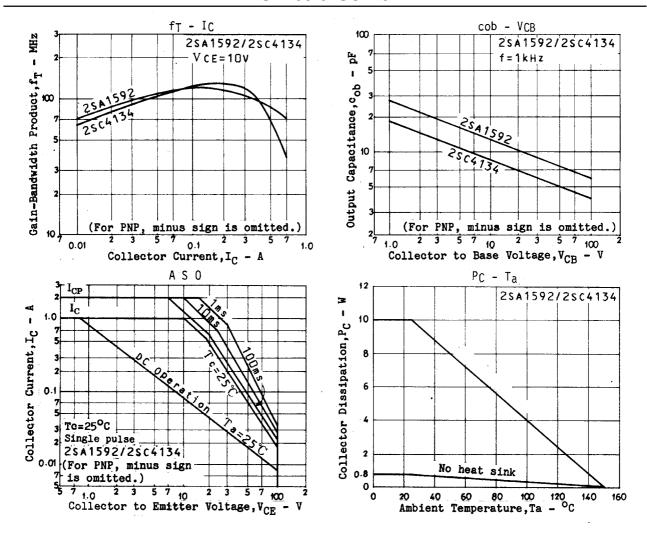
Parameter	Symbol	Conditions	Ratings			Unit
	Symbol		min	typ	max	Offic
Collector Cutoff Current	ICBO	V _{CB} =(-)100V, I _E =0			(-)100	nA
Emitter Cutoff Current	I _{EBO}	V _{EB} =(-)4V, I _C =0			(-)100	nA
DC Current Gain	h _{FE}	V _{CE} =(-)5V, I _C =(-)100mA	100*		400*	
Gain-Bandwidth Product	f _T	V _{CE} =(-)10V, I _C =(-)100mA		120		MHz
Output Capacitance	C _{ob}	V _{CB} =(-)10V, f=1MHz		8.5		pF
				(13)		pF
Collector-to-Emitter Saturation Voltage	V _{CE(sat)}	I _C =(-)400mA, I _B =(-)40mA		(-0.2)	(-0.6)	V
				0.1	0.4	V
Base-to-Emitter Saturation Voltage	V _{BE(sat)}	I _C =(-)400mA, I _B =(-)40mA		(-)0.85	(-)1.2	V
Collector-to-Base Breakdown Voltage	V _(BR) CBO	I _C =(-)10μΑ, I _E =0	(–)120			V
Collector-to-Emitter Breadown Voltage	V _(BR) CEO	I _C =(-)1mA, R _{BE} =∞	(–)100			V
Emitter-to-Base Breakdown Voltage	V _{(BR)EBO}	I _E =(-)10μΑ, I _C =0	(-)6			V
Turn-ON Time	ton	See specified Test Circuit		(80)		ns
				80		ns
Storage Time	t _{stg}	See specified Test Circuit		(700)		ns
				850		ns
Fall Time	t _f	See specified Test Circuit		(40)		ns
				50		ns

Switching Time Test Circuit









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